



Latest Advances in Electron Microscopy







You are cordially invited to attend the FEI and Analysis workshop at the IN Hotel, Novi Beograd on the 20th March 2014

FEI will be giving an overview of their latest electron beam technologies at the workshop as well as proudly introducing their new exclusive agent for Serbia, Analysis.

At the workshop Daniel Phifer will present FEI's SEM and FIBSEM solutions with talks entitled Advances in DualBeamTM technology for characterization, sample preparation and 3D tomography and New Information from state of the art Scanning Electron Microscopy.

Mauro Porcu will be presenting FEI's TEM solutions for both life science and materials science in two separate lectures titled the Life Science FEI TEM workflow: Cryo-electron microscopy and Advanced Analytical Characterization: FEI TEM solutions for Materials Science.

Steve Hant, FEI's area manager for Serbia, and Analysis, FEI's new distributor and service agent, will also be presenting

Program

15:00 - 15:15

Wrap Up

9:40 - 10:00 Welcome from FEI and Analysis New information from state of the art Scanning 10:00 - 10:45 Electron Microscopy - Daniel Phifer 10:45 - 11:15 Coffee Break Advanced Analytical Characterization: FEI TEM 11:15 - 12:00 Solutions for Materials Science - Mauro Porcu 12:00 - 13:00 Lunch Advances in DualBeam technology for characterization, 13:00 - 13:45 sample preparation and 3D tomography - Daniel Phifer 13:45 - 14:15 Coffee Break The Life Science FEI TEM workflow: Cryo-electron 14:15 - 15:00 microscopy - Mauro Porcu

To confirm your attendance please contact us through: Email:- info@analysis.rs Telephone:- +381 11 318 64 46





